





Performance Innovation Reliability



JASCO developed the first infrared spectrophotometer, the DS-101, in 1954. Since then, we have developed a long line of innovative products that has led us to the new compact FT/IR-4X (footprint only 386 mm W  $\times$  479 mm D), and a 30 % reduction in power consumption. The 4X has functionality and expandability only seen in research grade instruments, for wavelength resolution, signal-to-noise, multiple detectors, expansion of the measurement range, rapid scanning and IR microscopy (including linear array).

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# A Compact, Powerful, Research-Grade Tool

# Specially controlled diode laser

• Compact, long-life diode laser with excellent wavenumber precision



- Optional halogen lamp
- Automatic switching

(0)

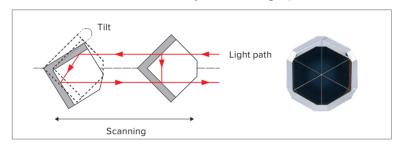
STATUS

#### Sealed interferometer

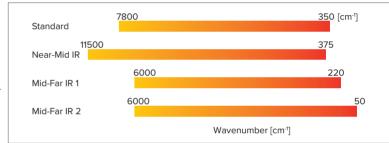
- 45° Michelson interferometer
- High-throughput Ge/KBr beam splitter
- Accurate moving-mirror control using DSP • Continuous temperature and humidity monitoring
- Only replace desiccants as needed

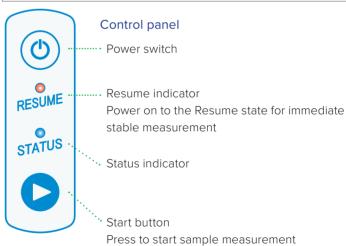
#### Corner-cube mirrors

• Corner-cube mirrors automatically correct for light path deviation



# Optional wavenumber measurement ranges





# High sensitivity cooled DLATGS detector

- Peltier element maintains optimum temperature to maximize performance
- Non-hygroscopic KRS-5 detector window

# Automatic validation wheel

Set automatically for selected resolution

Automatic aperture wheel

- NIST traceable polystyrene
- Automatic daily performance check





**KRS-5** window

• Moisture-resistant KRS-5 interferometer window



T/IR-4X + IRT-7200 linear array microscope

# Can be used with IR microscope

• Compatible with JASCO IRT-5000/7000 Series\*

#### Full size sample compartment

- Use with accessoried up to 200 mm wide
- iQX recognition automatically sets measurement parameters
- Smart Purge enables purging of compatible accessories

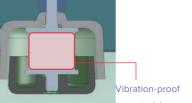




FT/IR-4X + 12 m Gas cell

#### Optical base

- Ribbed aluminum casting optical base with vibration-proof mounting
- Stable measurement over a long period



Leg structure

materials



FT/IR-4X

FT/IR-4X + MCT detector

#### External detector

- Automatic selection of a second detector (MCT, InGaAs, etc)
- Interchangable external detectors



# Measurement Accessories

#### ATR PRO 4X

ATR-Pro4X is fully integrated, but can easily be exchanged with other sampling accessories. The external design is easy to clean with a fully rotatable (360 deg) anvil for full access when placing samples onto the prism. The prisms are matched to the high pressure anvil (up to 10,000psi) with a slip clutch that prevents damage to softer prism materials. The choice of single reflection ATRs include monolithic diamond with anti-reflection coating for high throughput and wide range (a non-coated version is available for far-IR applications), ZnSe and germanium for highly absorbing black carbon loaded materials.



# View and record your samples

The ATR Pro 4X View has the same features as the Pro 4X, but also includes a viewing lens and camera to observe the sample directly through the prism crystal. Confirm the quality of contact, identify the actual measurement position of the sample, and record an image with the saved spectrum.

When the prism is exchanged the crystal material is automatically recognized from its spectrum

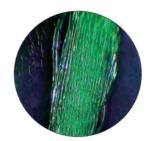
iQX automatically recognizes accessory and activates the measurement parameters used last time.







Unrestricted access to the ATR prism enables measurement of large samples.



A high-resolution camera for recording sample images with excellent clarity

The FT/IR-4X has a compact design with small footprint, but retains a sample compartment large enough to take a full range of accessories.

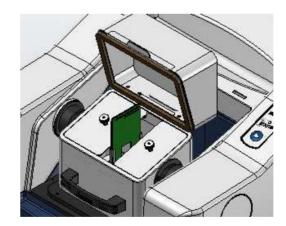


Comparison with conventional models

(FT/IR-4000 series)

It saves about 40 % of the space in the installation area

#### **Optional Sample Compartments**



TSC-4X Small and purgeable for transmittance measurements

The reduced volume of the internal sample compartment improves the purge time and reduces consumption of purge gas.

The effects of atmospheric gases are also reduced when used in non-purge mode.



ESC-4X

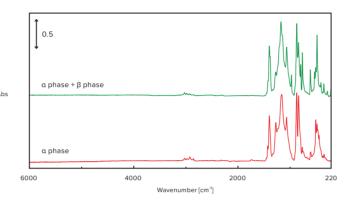
Optional sample compartment for large accessories up to 260 (D) x 185 (H) mm

6 excellent clarity

# **Expand the measurement range from NIR to FAR**

The standard Mid IR is typically defined from 7,800 to 350 cm<sup>-1</sup>. But with the development of new beam-splitter materials the measurement range of the FT/IR-4X can be dramatically expanded from the NIR to MIR, or from the MIR to the FIR. The light source, beam splitter, interferometer window and detector can be selected to optimize each measurement range.

	Quantitative analysis with chemometrics / Film thickness		
Near IR	measurement		
	Optical property measurement		
	Qualitative analysis / Identification analysis / Partial		
Mid IR	quantitative analysis		
Far IR	Crystal structure analysis / Inorganic sample analysis		



Wavenumber Ranges

NMIR-4X: Near to Mid IR 11,500 - 375 cm<sup>-1</sup> MFIR-4X-N: Mid to Far IR 6,000 - 220 cm<sup>-1</sup> MFIR-4X-W: Mid to Far IR 6,000 - 50-1

Measurement for PVDF in Mid-Far IR range

Examples of applications that require an extended wavenumber range

## **Example of Near IR Analysis in Pharma**



Quantification of multi-component mixed sample analysis using chemometrics

#### Mixed powder sample:

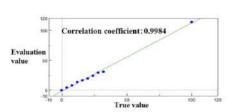
Ethenzamide and lactose hydrate mixed in the range of 4: 96 to 32:64 in 4% increments..

#### Measurement:

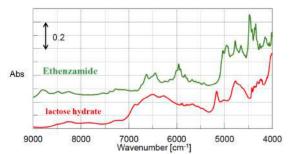
Rotate the petri dish to allow for spatial average in the variation in mixing.

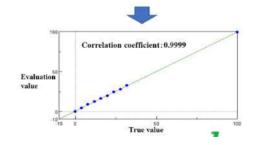
Quantitative method: Partial Least Squares





Calibration curve of ethenzamide created by measuring the sample at each area (red circle)



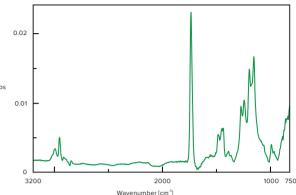


Calibration curve of ethenzamide prepared by averaging 16 measurements at each sample position.

# **Optional Detectors**

A optional range of user exchangeable detectors can be used to change wavenumber range and sensitivity (including MCT, InGaAs).

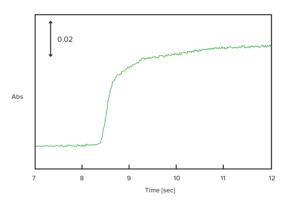


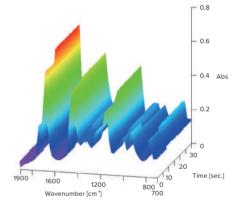


RAS measurement of PMMA thin film with MCT detector

# **Rapid Scan Option**

Optional rapid-scan measurement at up to 80 Hz. (16 cm-1 resolution) can be used to monitor kinetic reactions at high speed.





Reaction process of the UV-curing resin (using the MCT detector)

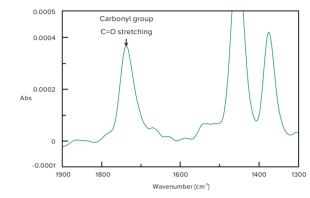
	25000	15000	5000	1000	400	20 (cm
Light source		Halogen lamp (25,000 - 2	2,200)			
Light source				High-intensity ceramic sour	ce (7,800 - 20)	
		Quartz broad band (25,000 - 4	, ,			
Beam sp <del>litter</del>			Si/CaF <sub>2</sub> (15,000 - 1,200)			
			KBr broad band (1	<u> </u>		
			Ge/Ki	3r (7,800 - 350) Mid-far IR broad bar	-4 (C 000 20)	
				iviid-iar ik broad bar	Mylar broad band (6	30)
					Mylar 5 um (630 - 15)	
					Mylar 12 um	
						ım (110 - 20)
						50 um (60 - 20)
	Si Photodiode	(visible) (25,000 - 10,000)				
		Si Photodiode (NIR)	(15,000 - 8,600)			
		InGa	As (11,500 - 4,000)			
			InSb (11,500 - 1,850)			•
			· ·	5,000 - 750)		
Detector			MCT-M (11,500 - 650)			
Detector			MCT-W (11,500 -			
			DLATGS (Mid IR) (15,000 -	•		,
			DLATGS (Far IR) (15,000			
			DLATGS (Broa	d band) (15,000 - 30)	DLATGS (PE window) (70	10 30)
	-				Si Bolometer (65	
			Diamond (25,000 - 20)		31 BOIOITIELEI (US	0 - 20)
		CaF <sub>2</sub> (25,000 -	` , , ,			
Window		ca. 7 (25)500	KRS-5 (Mid IR) (15,000 - 3	50)		
vviiid0w			KRS-5 (Far IR) (15,000 -	•		
			. , ,		PE (700 - 20)	
Mirror			Al coating (25,000 - 20)			
			Au coating (19,00	00 - 20)		

# Performance

#### **Excellent S/N Ratio**

The standard FT/IR Pro 4X includes many novel features for fast measurement of small or low concentration samples and for IR microscopy measurement with high sensitivity. These include a 24-bit A/D converter, low-noise electrical system, a high-intensity ceramic light source, peltier cooled DLaTGS detector and a high-throughput optical system all contribute to an excellent signal to noise (S/N) of 35,000 : 1\*. Higher S/N can be achieved using the optional MCT and InGaAs detectors.

\*Under standardized parameters.



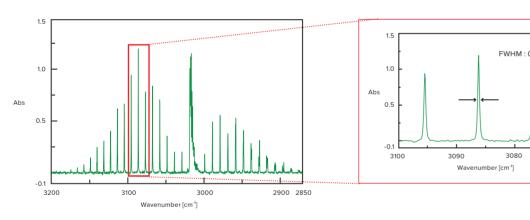
%T 40 3000 2000 1000 500

Coating on food packaging wrap film (ATR measurement)

PS film with  $\phi 0.5$  mm size (Transmittance measurement)

# **High Resolution**

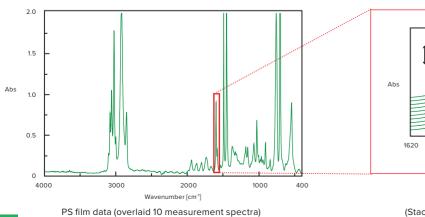
Resolution can be measured down to 0.4 cm-1 ideal for gas analysis and quantitation. The light path aperture is automatically set to the optimal size for spectral resolution.



Transmittance spectrum of  $CH_4$  (methane) gas (using a 10 cm gas cell)

# **Exceptional Wavenumber Precision**

The specially controlled diode laser (VCSEL) has an extremely long and stable lifetime and contributes to the downsizing of the instrument. By oscillating the laser with high precision using XLD, the FT/IR-4X has a wavenumber precision of 0.0005 cm-1 comparable what can be achieved with a HeNe laser.



Abs 0.25

1620 1610 1600 1590 1580 Wavenumber [cm \*]

Peak position stability (Stacked display of 10 measurement spectra)



# SPECTRA MANAGER™

# A SINGLE PLATFORM FOR EVERY INSTRUMENT.

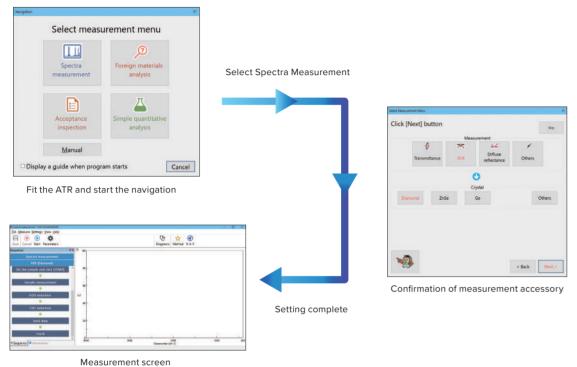
JASCO has developed the unique and powerful, cross-platform Windows® software package to control the widest range of optical spectroscopy instrumentation. Spectra Manager™ is a comprehensive lab companion for measuring and processing data, eliminating the need to learn multiple software programs and allowing data from many instruments to be analyzed and displayed together on the same platform.

# Spectra Manager<sup>™</sup> Software Suite

Spectra Manager Ver. 2.5 includes a navigation function that allows those users who may be unfamiliar with IR analysis to perform measurements in exactly the same way as an expert. The parameters set using the navigation function allows the measurement to be started from a pre-defined method.

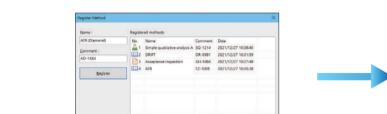
## **Navigation**

Parameters suitable for the measurement are selected from the menu.



#### Method function

Define frequently used measurement parameters into methods, perform the measurement by just selecting the method from an icon.



Registering method

# OK Cancel

## **Regulatory Compliance**

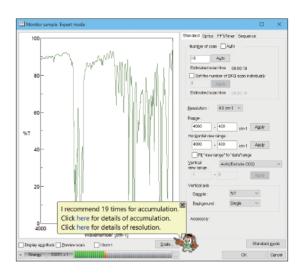
measurement/analysis.

Developed using the latest requirements of ALCOA +, a requirement for data integrity, Spectra Manager 2.5 CFR is available to support the requirements of electronic signature with 21 CFR part 11 compliance. \*Note: The Spectra Manager 2.5 CFR may differ from Spectra Manager 2.5 in terms of the contents and operations of



Click [Next] button I recommend a Diamond crystal typicall Click here for characteristics of each

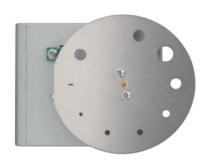
Advice on navigation



Advice on parameter setting

#### Auto validation

Auto validation The NIST traceable polystyrene standard reference material for validation is installed inside the interferometer, and can be used to monitor performance Using the Daily Check validation program The polystyrene standard can be recalibrated periodically without removal from the system.

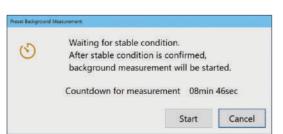


Automatic validation wheel

Validation result

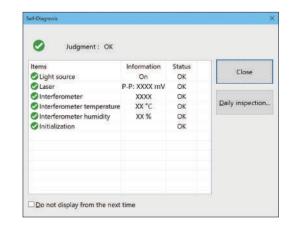
#### Preset background measurement

Background measurement can be made automatically after the instrument has stabilized. In addition, stable data can be ensured by setting background remeasurement at selected intervals.



#### Self-diagnosis

The self-diagnosis is made when the instrument in powered on. Any issues will be detected immediately. The results of each power-on self-diagnosis is recorded automatically, and the history can be used to track changes over time.



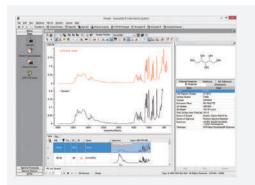
User management (user registration)

Audit trail (application log)

# KnowltAll® JASCO Edition Spectral Search

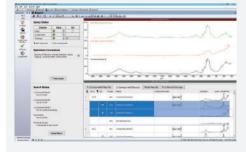
Wiley KnowltAll® Informatics System, JASCO Edition is included\* with the FT/IR-4 series instruments. This comprehensive data search database and analysis software includes the following features:

- Free access (for 90 days after software activation) to the database libraries, including 264,000 IR spectra (HaveItAll®), and life time unrestricted access to the data library including 12,600 spectra of general chemical and polymers.
- Search JASCO's own data library including 400 spectra of organic and inorganic compounds.



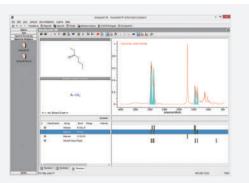
#### **SearchIt**<sup>™</sup>

Search against reference databases as well as your own imported spectra. Searches are customizable and driven by powerful algorithms. Searchable fields include name, structure, substructure, properties, and analytical data, such as spectra and peaks.



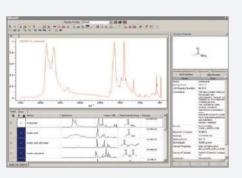
## **ID Expert**<sup>™</sup>

ID Expert automatically performs a series of basic analyses, single and multi-component search, peak search, and functional group analysis.



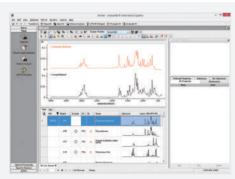
## Analyzelt™

Interpret the bands in an infrared spectrum. Simply load a spectrum and click on a peak of interest to generate a list of possible functional groups at that position. Analyzelt features over 200 functional groups and hundreds of interpretation frequencies.



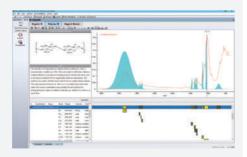
#### Minelt™

Searchable databases can be built for IR and NIR, chemical structures and other metadata. Databases can be customized for users needs. Convenient for QC labs.



# **Mixture Analysis**

Determine the components in a mixture. Just transfer the spectrum to be analyzed, the software searches and compares the samples to reference databases of known compounds and predicts the possible mixture of components.



# Analyzelt<sup>™</sup> Polymer IR

Useful in the identification of IR spectra of unknown polymers, classification/pattern characterization of polymers.

The KnowltAll® spectral database of 264,000 sample spectra is segmented into 120 easy to search individual ATR-IR - Controlled & Prescription Drugs, libraries.

## Polymers & Related Compounds: total 52,055 spectra

ATR-IR - Polymers

IR - Adhesives, plasticizers, polymers etc.

#### Pure Organic Compounds: total 166,545 spectra

ATR-IR - Standards

IR - Standards

IR - Alcohols, aldehydes, carboxylic acids, hydrocarbons, intermediates, vapors etc.

#### Industrial Compounds: total 21,975 spectra

IR - Fats, Waxes & Derivatives

IR - Lubricants, additives, solvents and petroleum products

IR - Surfactants

#### Forensic Sciences: total 21,635 spectra

Pharmaceuticals, Nutraceuticals

ATR-IR - Steroids and hormones

IR - Biochemicals, Abused drugs, dyes, explosives, fibers, flavors

IR - Canadian Forensics, Georgia State Crime lab

#### Environmental Application: total 6,350 spectra

IR - HA7MAT

IR - Pesticides, agrochemicals,

## Inorganics and Organometallics: total 2,560 spectra

ATR-IR - Inorganics, organometallics

IR - Inorganics, organometallics, minerals and clays

#### NIR: total 3,800 spectra

NIR - Common Organic Compounds

## ADSS-4000 Advanced Spectra Search program

The advanced spectral search program makes it possible for anyone to perform spectral analysis like an experienced operator. Using machine learning to perform classification without reference to a database, it can classify the spectrum of unknown samples into 35 different chemical categories. It can also simultaneously identify the compound by searching against a user editable library (Starting with approx. 600 spectra).



Carboxylic acids	Silicone	Urethanes
Carboxylic acid salts	Epoxy resins	Silica
Carboxylic acid esters	Polyethers	Silica (talc)
Carboxylic acid esters (oil)	Polyethers (polyacetal)	Silica (kaolin)
Proteins	Fluorides	Carbonates
Polyamides	Styrene	Sulfates
Cellulose and sugar	Polycarbonates	Polyimides
Hydrocarbons	Nitriles	Phosphates
Hydrocarbons (polyethylenes)	Phenolic resins	Water
Hydrocarbons (polypropylenes)	Polyvinyl acetates	Acetone
Acrylic resins	Polyvinyl chlorides	Alcohol
Polyesters	Polyvinyl alcohol	

\*Except LE versions

# FTIR Sampling Accessories

# **FTIR Sampling Accessories Attenuated Total Reflectance Measurement**

The FT/IR-4X series includes a comprehensive range of ATR accessories for sample measurement. The ATR Pro 4X and ATR Pro 4X View are the 'signature' single reflection monolithic diamond models with wide spectral range and high optical throughput. Versatile models include: wide range sample temperature control, polarization and environmental control.

#### ATR PRO 4X

#### **Single-Reflection ATR**

# Specifications

ATR prism: Wide-band type). ZnSe, Ge. ATR/sample contact area: 2.5 mm diameter (ZnSe, Ge) 1.8 mm diameter (Diamond)

**High-Pressure Single-Reflection ATR** 

No. of reflections

ATR PRO470-H

Specifications

No. of reflections

ATR prism:

Angle of incidence 400 kg/cm<sup>2</sup> (ZnSe, Ge)



#### **Single-Reflection ATR with Camera**

#### Specifications

Diamond (High-throughput type and Wide-band type). ZnSe, Ge (without image)

2.5 mm diameter (ZnSe. Ge) 1.8 mm diameter (Diamond)

Angle of incidence:

400 kg/cm<sup>2</sup> (ZnSe, Ge) 700 kg/cm<sup>2</sup> (Diamond)

data file with Spectra Manager II



#### ATR PRO410-M Multi-Reflection ATR

#### Specifications

ATR/sample contact area: 5 x 20 mm

Angle of incidence:



# ATR PRO550S-S, ATR PRO570S-H

#### Sample-Shielding Single-Reflection ATR

Specifications ATR prism:

ZnSe, Ge, Diamond (550S-S) Diamond (570S-H) 15 mm diameter (7nSe Ge)

1,700 kg/cm<sup>2</sup> (Diamond)

2.0 mm diameter (Diamond) No of reflections

Anale of incidence:

400 kg/cm<sup>2</sup> (550S-S)



#### ATR PRO610P-S. ATR PRO630P-H **Polarizer Single-Reflection ATR**

ATR prism: ZnSe. Ge. Diamond (610P-S) Diamond (630P-H) 1.5 mm diameter (ZnSe. Ge) 2.0 mm diameter (Diamond)

No. of reflections Angle of incidence:

400 kg/cm<sup>2</sup> (610P-S) 1,700 kg/cm<sup>2</sup> (630P-H) Wire-grid polarizer (KRS-5)



# 65° Incident-Type Single-Reflection ATR

#### Specifications

ATR/sample contact area: 3.0 mm diameter

Angle of incidence:

ATR PRO650G

\* A polarizer and attenuator mesh are optional



#### ATR PRO670H-S, ATR PRO690H-H **Temperature Controlled Single-Reflection ATR**

ZnSe, Ge, Diamond (670H-S)

#### Specifications

Diamond (690H-H) 1.5 mm diameter (ZnSe, Ge)

2.0 mm diameter (Diamond)

Angle of incidence: 400 kg/cm<sup>2</sup> (670H-S)

1.700 kg/cm<sup>2</sup> (690H-H)

\* A connector panel is required when this accessory is fitted to the FT/IR-6000FV.



#### ATR PRO ONE T

#### **Large Sample Single-Reflection ATR**

#### Specifications

throughput type. Wide-band type ATR/sample contact area: 2.5 mm diameter (ZnSe, Ge)

18 mm diameter (Diamond)

Angle of incidence

400 kg/cm<sup>2</sup> (ZnSe, Ge) 700 kg/cm<sup>2</sup> (Diamond)



# **Grazing-Angle Reflectance Measurement**

Reflection Absorption Spectroscopy has the benefit of greater sensitivity - up to 1 or 2 orders of magnitude compared with transmission. When parallel polarized light is incident to a metal surface, the electric vectors in the incident and reflected light interfere to mutually strengthen and form a vertical standing wave. The interaction of this stationary wave with a thin film on the metal surface, causes an absorption that is stronger than simple transmission measurement.

# RAS PRO410-H

# 85° Incident Angle without Mirror

Optical system: Angle of incidence

Refractive optics

Polarizer/analyzer Wire-grid polarizer (KRS-5) Fixed at 0° to the plane of inci Polarizing direction

Sample placement

20 x 10 mm, 10 x 10 mm Sample mask: (Option: 10 x 5 mm)

Smart purge Available



# PR-510i

# Variable Incident Angle

#### Specifications

Angle of incidence Wire-grid polarizer (KRS-5)

Sample placement

Sample size: 30 x 40 mm



#### RAS PRO410-B 80° Incident Angle

# Specifications

Angle of incidence

PL-82 is required Sample placement 20 x 10 mm, 10 x 10 mm

IQ accessory Smart purge



#### RAS-300/Hi 75° Incident Angle

## Specifications

Sample mask:

Angle of incidence

polarization only)

20 x 10 mm, 10 x 10 mm



# **Diffuse and Specular Reflectance Measurement**

Diffuse reflectance is a useful technique for samples with a roughened surface which are not amenable to transmission or ATR measurement, such as some powders, pharmaceuticals, plastics and food products etc. The diverse range of diffuse reflectance products includes heated, vacuum and automatic sampling accessories.

#### DR PRO410-M

#### **Multi-Sample Diffuse Reflectance**

#### Specifications

IQ accessory

Smart purge:



# **Smart Tech Multi-Sample Diffuse Reflectance**

# Specifications

IQ accessory Smart purge:

Automatic sample switching is optiona



#### DR-650Ai Bi, Ci

#### Vacuum/Heated Diffuse Reflectance

#### Specifications Cell temperature

1000°C (Ai), 800°C (Bi), 600°C (Ci)

Sample size: 6 mm in diameter Available Gas flow: Kanthal heate

Cell cooling method Water-cooled Temperature controller and related software are optional



## **DR-81 Diffuse Reflectance**

#### Specifications

5-position sample holder



## NRF PRO410-N

#### **Near IR Diffuse Reflectance**

Specifications

Wavenumber range 15 000 - 4 000 cm<sup>-1</sup> Angle of incidence:

Snot size: 10 mm in diameter Diffusion plate for reference Reference materia IQ accessory: Available Test tube holder

Pellet holder

#### **RF-81S Specular Reflectance**

#### Specifications Anale of incidence

No. of reflections:

Sample mask: 1 3 and 5 mm in diameter







# Related Instruments

#### IRT-7200

The IRT -5200 is a simple to use and hghly productive accessory for hte FT/IR-4X, using a single MCT detector with options for near and far IR. automatic stage, IQ Mapping and IQ Frame make this the most versatile IR microscope JASCO has ever developed. The ClearView range of view through ATRs with pressure stage with repeatable contact make ATR mapping easy for users at every level.



#### IRT-7200

Imaging measurement is essential for analyzing/visualizing the chemical structure of samples. Conventional IR microscopes with single-element detector are most commonly used, but with the disadvantage that the measurement time can be quite long. Using a 16 element MCT detector with high-speed automatic XYZ stage,the IRT-7200 can perform high-speed mapping measurement, up to a hundred times faster than a single-element detector.



#### VFT-4000

The VFT-4000 is a VCD attachment for the FTIR spectrometers, for measuring vibrational circular dichroism in the infrared region. The VFT-4000 can be used to obtain information about optical activity and absolute stereochemistry. Since the CD signal sare externely small, stability and sensitivity are essential. The VFT-4000 offers highly stable and sensitive measurement using lockin detection using a DSP (digital signal processor) with sophisticated algorithm optimized for VCD as well as thermal control of the optical system.



# **Specifications**

Hardware			
Measurement Wavenumber Range	7,800 - 350 cm <sup>-1</sup>		
Measurement Wavenumber Extended Range <sup>11</sup> (optional)	11500 to 375 cm <sup>-1</sup> (NMIR-4X) 6000 to 220 cm <sup>-1</sup> (MFIR-4X-N) 6000 to 50 cm <sup>-1</sup> (MFIR-4X-W)		
Resolution	0.4, 0.5, 1.0, 2, 4, 8, 16 cm <sup>-1</sup>		
Signal-to-Noise Ratio <sup>*2</sup>	35,000:1		
	Standard	DLATGS (with Peltier temperature control)	
Detector	Optional	MCT-N, MCT-M, MCT-W, MCT-PV, InGaAs, Broad band DLATGS *3, PAS (PC switching, User exchangeable)	
	Standard	Ge/KBr	
Beam Splitter	Optional	Broad band KBr, Mid-far IR broad band (not interchangeable)	
Light Source	Standard	High-intensity ceramic source	
Light Source	Optional	Halogen lamp (PC switching)	
Interferometer	45° Michelson interferometer with corner-cube mirror, sealed structure (KRS-5 window), auto-alignment mechanism, DSP control		
Purging (standard)	Standard	Sample/detector compartment	
Turging (standard)	Optional	Interferometer	
A/D Converter	24-bit A/D converter		
Drive Method	Mechanical bearing, electromagnetic drive		
Drive Speed	1, 2, 3, 4 mm/sec Rapid scan: 32, 64 mm/sec.		
Rapid Scan <sup>-4</sup> (optional)	80 spectra/sec. (16 cm <sup>-1</sup> resolution)		
Communication	USB 2.0		
Vibration-Proof	Vibration-proof design mounting		
iQX Accessory	Standard		
Start Button	Standard		
Dimensions and Weight	386 (W) × 479 (D) × 254 (H) mm, 18 kg		
Required Power	AC 100 to 240 V, 50/60 Hz, maximum 50 VA		
Operation Environment	Temperature: 17 to 27 °C / humidity: less than 70 %		
Data Processing			
Software	JASCO Spectra Manager Ver.2.5 '5		
Operating System	Windows 10 Pro (64-bit)		

<sup>&</sup>lt;sup>1</sup> One of three options (near-mid IR region, mid-far IR region) should be selected when extending the measurement wavenumber range.

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<sup>&</sup>lt;sup>\*2</sup> Measurement condition: 4 cm-1 resolution, 1 minute accumulation, near 2200 cm-1, P-P

<sup>\*3</sup> Broad band DLATGS is installed instead of DLATGS as standard detector when selecting the far IR extension option.

<sup>\*4</sup> Performance of rapid scan function was evaluated when installing Ge/KBr beam splitter. MCT detector is also required.

<sup>&</sup>lt;sup>\*5</sup> JASCO can provide Spectra Manager Ver.2.5 CFR which is compliant with FDA 21 CFR PART 11. \* Installation area for PC and printer



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